# Study of Fluctuations in Undulator Radiation in the IOTA Ring at Fermilab

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## Abstract:

#1

#2

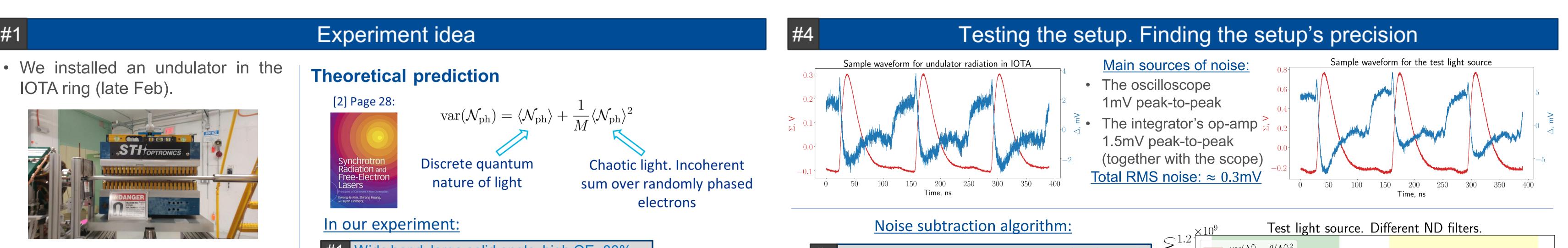
We study turn-by-turn fluctuations in the number of emitted photons in an undulator, installed in the IOTA electron storage ring at Fermilab, with an InGaAs PIN photodiode and an integrating circuit. In this paper, we present a theoretical model for the experimental data from previous similar experiments and in our present experiment, we attempt to verify the model in an independent and a more systematic way. Moreover, in our experiment we consider the regime of very small fluctuation when the contribution from the photon shot noise is significant, whereas we believe it was negligible in the previous experiments. Accordingly, we present certain critical improvements in the experimental setup that let us measure such a small fluctuation.



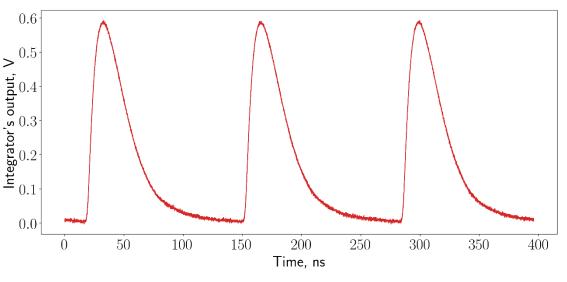
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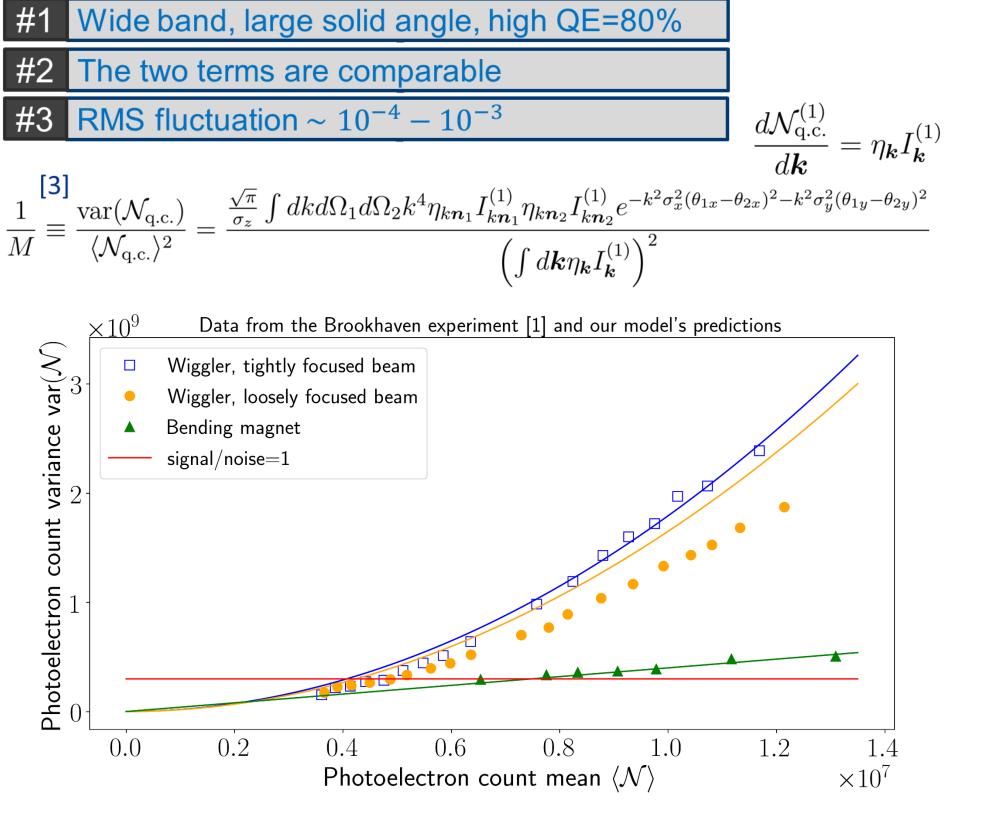


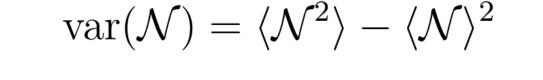


• And built an integrating circuit for photodiode's current. The the amplitude of the output voltage was proportional to the number of photoelectrons generated in the photodiode.

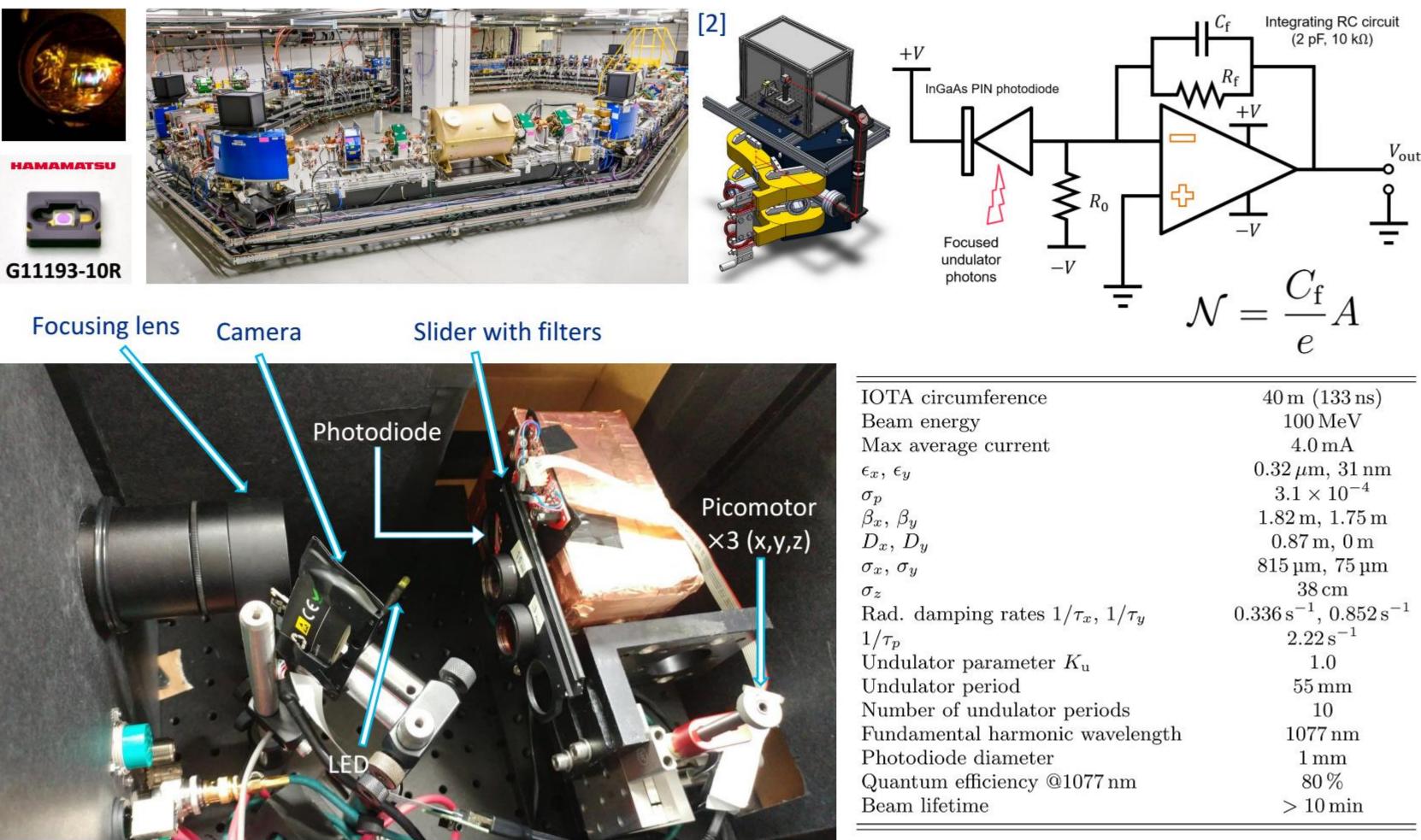


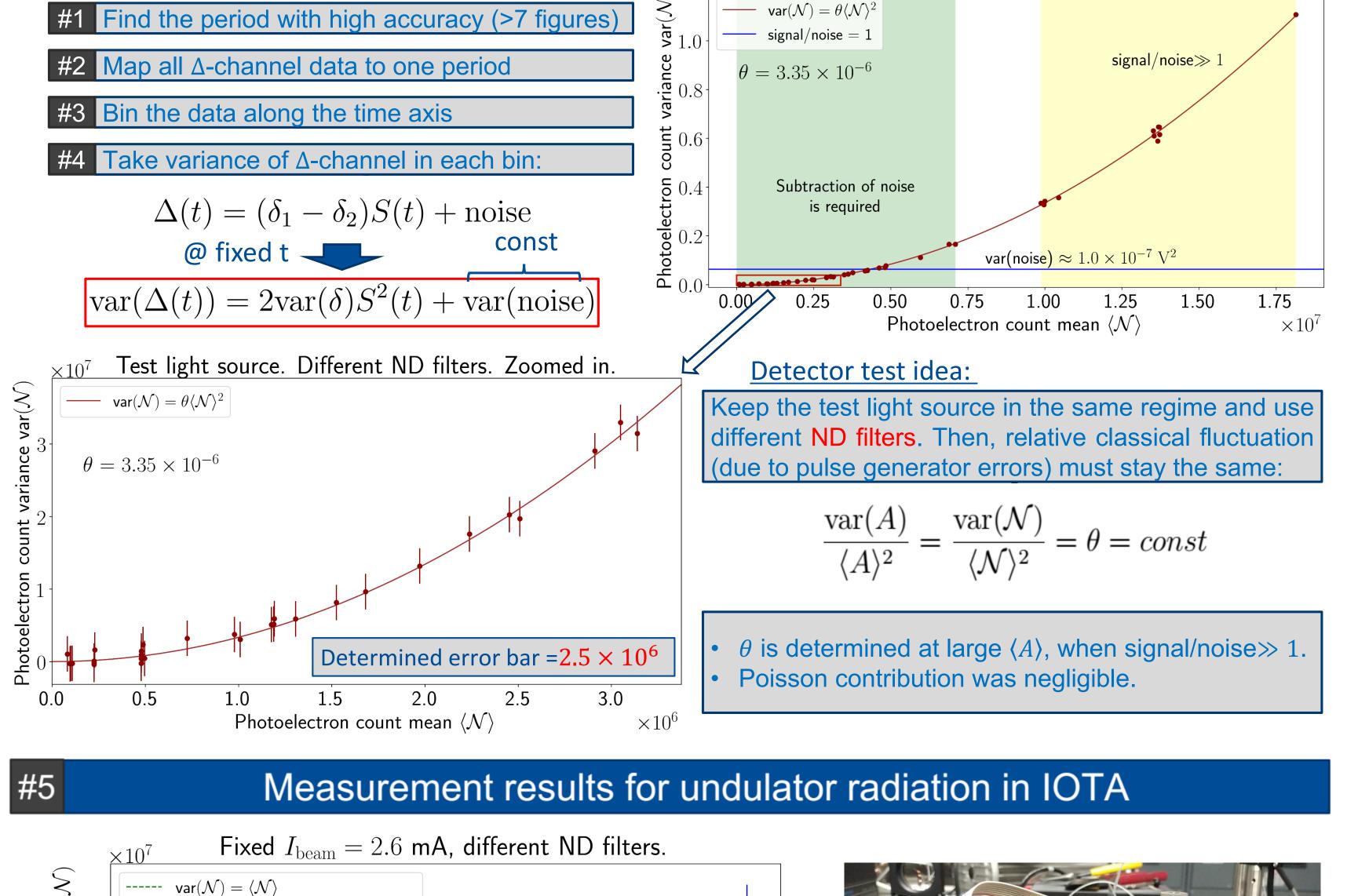
• In the experiment (late Mar), we the fluctuation in the studied number of photoelectrons, namely, the variance:



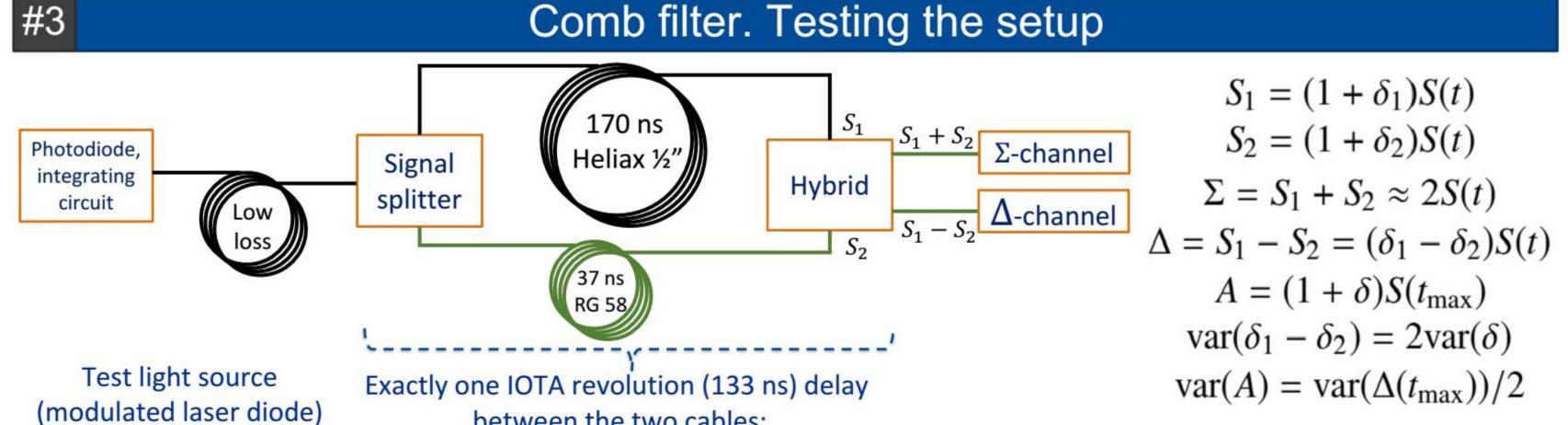


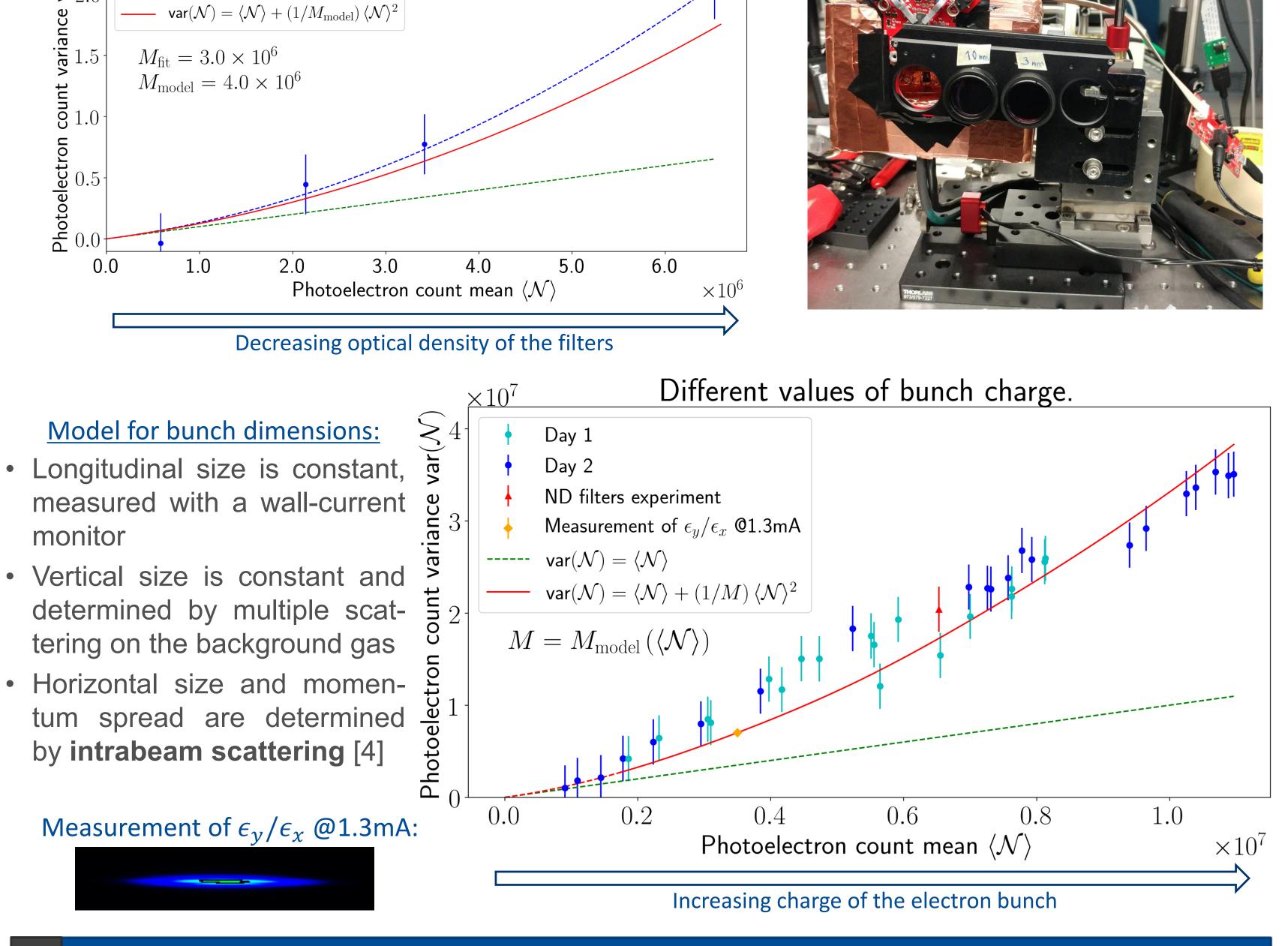
## Experiment layout. Main parameters



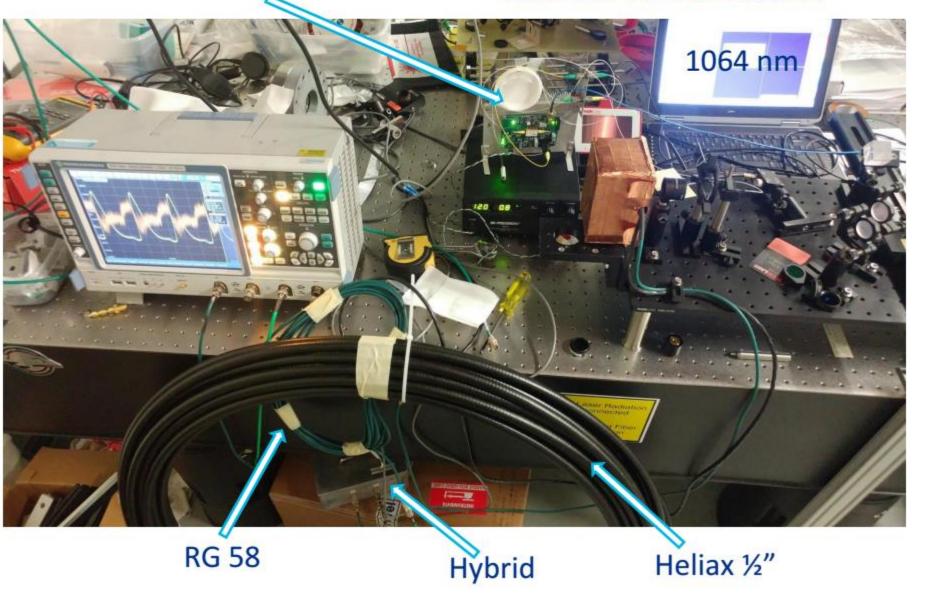


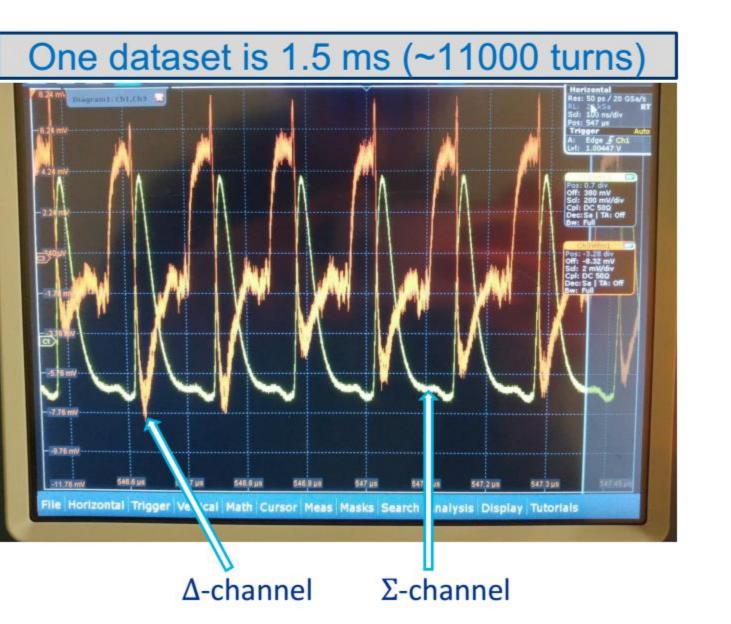
undulator –V	$\mathcal{N} = \frac{C_{\rm f}}{e} A$
IOTA circumference	$40 \mathrm{m}  (133 \mathrm{ns})$
Beam energy	$100{ m MeV}$
Max average current	$4.0\mathrm{mA}$
$\epsilon_x,\epsilon_y$	$0.32\mu\mathrm{m},31\mathrm{nm}$
$\sigma_p$	$3.1 \times 10^{-4}$
$\beta_x,\beta_y$	$1.82{ m m},1.75{ m m}$
$D_x, D_y$	$0.87\mathrm{m},0\mathrm{m}$
$\sigma_x,\sigma_y$	$815\mu m,75\mu m$
$\sigma_z$	$38\mathrm{cm}$
Rad. damping rates $1/\tau_x$ , $1/\tau_y$	$0.336{ m s}^{-1},0.852{ m s}^{-1}$
$1/ au_p$	$2.22{ m s}^{-1}$
Undulator parameter $K_{\rm u}$	1.0
Undulator period	$55\mathrm{mm}$
Number of undulator periods	10
Fundamental harmonic wavelength	$1077\mathrm{nm}$
Photodiode diameter	$1\mathrm{mm}$
Quantum efficiency @1077 nm	80%
Beam lifetime	$> 10 \min$





#### between the two cables:





#6

-----  $\operatorname{var}(\mathcal{N}) = \langle \mathcal{N} \rangle + (1/M_{\mathrm{fit}}) \langle \mathcal{N} \rangle^2$ 

## Conclusions

Quantitative theoretical model for the experiment from [1] was developed and verified in an independent experiment in IOTA [3]. It helped corroborate a model of intrabeam scattering in IOTA [4]. The agreement is expected to improve in the future. Along with measurements of longitudinal bunch size [5-8] the fluctuations can be used to measure transverse bunch size.

### Improvements as compared to the similar experiment from [1]:

- Better precision due to using the comb filter with one-turn delay and the special noise subtraction algorithm.
- Fluctuations data collected for different values of bunch charge.
- The transition from Poisson statistics to Super-Poisson statistics was observed in undulator radiation for the first time.

[1] M. C. Teich, T. Tanabe, T. C. Marshall, and J. Galayda, [4] S. Nagaitsev, Intrabeam scattering formulas for fast in incoherent radiation, Phys. Rev. Lett. 82, 5261 (1999). V. Sajaev, Measurement of bunch length using specnumerical evaluation, Phys. Rev. ST Accel. Beams 8, [7] Statistical properties of wiggler and bending-magnet ratral analysis of incoherent radiation fluctuations, in AIP diation from the Brookhaven Vacuum-Ultraviolet elec-064403 (2005). Conf. Proc., Vol. 732 (AIP, 2004) pp. 73–87. [5] F. Sannibale, G. Stupakov, M. Zolotorev, D. Filippetto, tron storage ring, Phys. Rev. Lett. 65, 3393 (1990). and L. Jägerhofer, Absolute bunch length measurements [8] V. Sajaev, Determination of longitudinal bunch profile [2] K.-J. Kim, Z. Huang, and R. Lindberg, Synchrotron rausing spectral fluctuations of incoherent radiation, Reby incoherent radiation fluctuation analysis, Phys. Rev. diation and free-electron lasers (Cambridge University port No ANL/ASD/CP-100935 (Argonne National Lab-ST Accel. Beams **12**, 032801 (2009). Press, 2017). [3] I. Lobach, V. Lebedev, S. Nagaitsev, A. Romanov, [6] P. Catravas, W. Leemans, J. Wurtele, M. Zolotorev, oratory, 2000). M. Babzien, I. Ben-Zvi, Z. Segalov, X.-J. Wang, and G. Stancari, A. Halavanau, Z. Huang, and K.-J. Kim, V. Yakimenko, Measurement of electron-beam bunch Intensity fluctuations in undulator radiation, will be sublength and emittance using shot-noise-driven fluctuations mitted to PRAB.